Applicant(s)/Patent Under Application/Control No. Reexamination 10/721,028 QIU ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1657 David M. Naff **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name MM-YYYY Country Code-Number-Kind Code 424/422 08-1986 Graves et al. US-4,604,097 Α US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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